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## FQD8P10TM-F085

#### **100V P-Channel MOSFET**

#### **General Description**

These P-Channel enhancement mode power field effect transistors are produced using ON Semiconductor's proprietary, planar stripe, DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for low voltage applications such as audio amplifier, high efficiency switching DC/DC converters, and DC motor control.

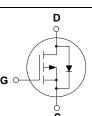
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D-PAK

#### Features

- -6.6A, -100V, R<sub>DS(on)</sub> = 0.53Ω @V<sub>GS</sub> = -10 V
- Low gate charge (typical 12 nC)
- Low Crss (typical 30 pF)
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability
- Qualified to AEC Q101
- RoHS Compliant





#### Absolute Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted

| Symbol                            | Parameter   |          | Ratings |      | Units |
|-----------------------------------|---|----------|---------|------|-------|
| V <sub>DSS</sub>                  | Drain-Source Voltage  |          | -100    |      | V     |
| I <sub>D</sub>                    | Drain Current - Continuous (T <sub>C</sub> = 25°                              | °C)      | -6.6    |      | А     |
|                                   | - Continuous (T <sub>C</sub> = 100°C)   |          | -4      | Α    |       |
| I <sub>DM</sub>                   | Drain Current - Pulsed  | (Note 1) | -26     | 6.4  | Α     |
| V <sub>GSS</sub>                  | Gate-Source Voltage   |          | ±;      | 30   | V     |
| E <sub>AS</sub>                   | Single Pulsed Avalanche Energy  | (Note 2) | 15      | 50   | mJ    |
| I <sub>AR</sub>                   | Avalanche Current   | (Note 1) | -6      | .6   | А     |
| E <sub>AR</sub>                   | Repetitive Avalanche Energy   | (Note 1) | 4.      | .4   | mJ    |
| dv/dt                             | Peak Diode Recovery dv/dt   | (Note 3) | -6      | .0   | V/ns  |
| P <sub>D</sub>                    | Power Dissipation (T <sub>A</sub> = 25°C) *                                   |          | 2.5     |      | W     |
|                                   | Power Dissipation ( $T_C = 25^{\circ}C$ )                                     |          | 4       | 4    | W     |
|                                   | - Derate above 25°C   |          | 0.3     | 35   | W/°C  |
| T <sub>J</sub> , T <sub>STG</sub> | Operating and Storage Temperature Rat   | nge      | -55 to  | +150 | °C    |
| ΤL                                | Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds |          | 300     |      | °C    |
| Thermal                           | Characteristics   |          |         |      |       |
| Symbol                            | Parameter   |          | Тур     | Max  | Units |
| $R_{\theta JC}$                   | Thermal Resistance, Junction-to-Case  |          |         | 2.84 | °C/W  |

\* When mounted on the minimum pad size recommended (PCB Mount)

Thermal Resistance, Junction-to-Ambient \*

Thermal Resistance, Junction-to-Ambient

 $R_{\theta JA}$ 

 $R_{\theta JA}$ 

°C/W

°C/W

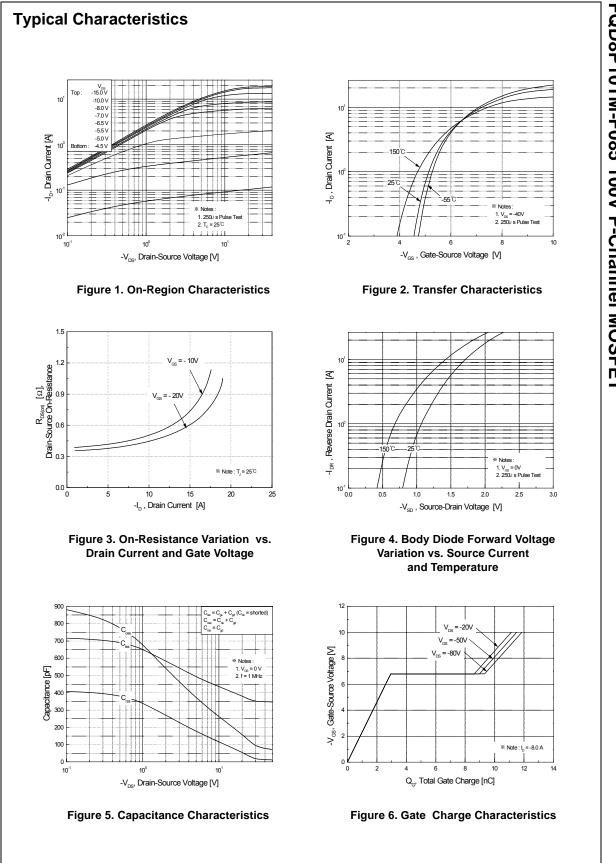
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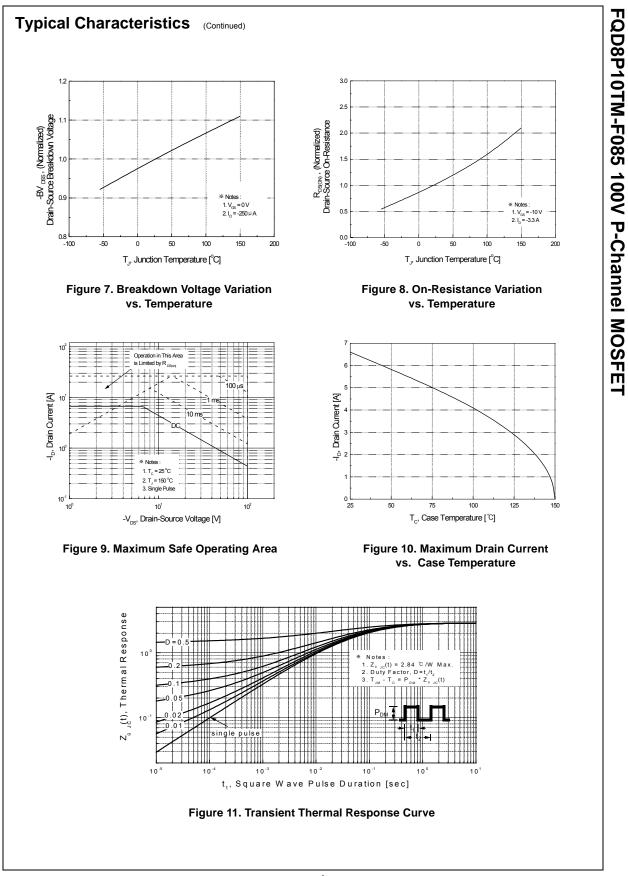
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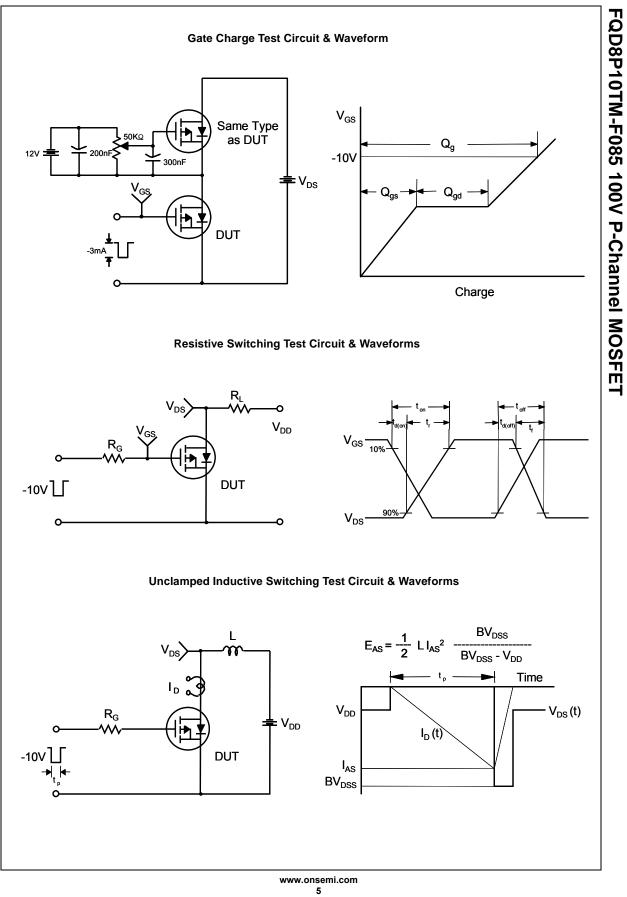
| $\begin{array}{c c c c c c c c c c c c c c c c c c c $   | Symbol  | Parameter  | Test Conditions  | Min  | Тур         | Max   | Units |
|--|---|--|--|------|-------------|-------|-------|
| $\begin{array}{c c c c c c c c c c c c c c c c c c c $   | Off Cha   | racteristics   |  |      |             |       |       |
| $\begin{array}{c c c c c c c c c c c c c c c c c c c $   | BV <sub>DSS</sub>   |  | V <sub>GS</sub> = 0 V, I <sub>D</sub> = -250 μA                                  | -100 |             |       | V     |
| Zero Gate Voltage Drain Current $V_{DS} = -80 \text{ V},   \text{C} = 125^{\circ}\text{C}$ 10 $\mu \text{A}$ SSSFGate-Body Leakage Current, Forward $V_{GS} = -30 \text{ V}, V_{DS} = 0 \text{ V}$ 100nASSSRGate-Body Leakage Current, Reverse $V_{GS} = 30 \text{ V}, V_{DS} = 0 \text{ V}$ 100nAOn CharacteristicsGS(th)Gate Threshold Voltage $V_{DS} = V_{GS}, \text{ Ip} = -250 \mu \text{A}$ -2.04.0VDS(on)Static Drain-Source<br>On-Resistance $V_{GS} = -10 \text{ V}, \text{ Ip} = -3.3 \text{ A}$ 0.410.53 $\Omega$ FSForward Transconductance $V_{DS} = -40 \text{ V}, \text{ Ip} = -3.3 \text{ A}$ 0.410.53 $\Omega$ FranceV_{DS} = -40 \text{ V}, \text{ Ip} = -3.3 \text{ A}0.410.53 $\Omega$ FranceV_{DS} = -25 \text{ V}, V_{GS} = 0 \text{ V}, \text{ Ip} = -3.3 \text{ A}0.410.53 $\Omega$ FranceV_{DS} = -25 \text{ V}, V_{GS} = 0 \text{ V}, \text{ Ip} = -3.3 \text{ A}0.40pFMynamic CharacteristicsF100 \text{ MHz}120 \text{ 155 pF}FrassReverse Transfer CapacitanceV_{DS} = -50 \text{ V}, \text{ Ip} = -8.0 \text{ A}, \text{110 230 ns(off)Turn-On Rise TimeN35 80 nsns(off)Turn-Off Fall TimeV_{DS} = -80 \text{ V}, \text{ Ip} = -8.0 \text{ A}, \text{12 15 nC(gate Gate-Drain ChargeV_{DS} = -10 \text{ V}3.0nC(gate Gate-Drain ChargeV_{DS} = -10 \text{ V}<   | ABV <sub>DSS</sub>  |  | $I_D = -250 \ \mu$ A, Referenced to 25°C   |      | -0.1        |       | V/°C  |
| VDS   = -80 V, I_C = 125 °C      10 $\mu A$ SSSF   Gate-Body Leakage Current, Forward   V <sub>GS</sub> = -30 V, V <sub>DS</sub> = 0 V      100   nA     SSR   Gate-Body Leakage Current, Reverse   V <sub>GS</sub> = 30 V, V <sub>DS</sub> = 0 V     100   nA     On Characteristics   SG(h)   Gate Threshold Voltage   V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = -250 $\mu A$ -2.0    -4.0   V     DS(on)   Static Drain-Source<br>On-Resistance   V <sub>DS</sub> = -10 V, I <sub>D</sub> = -3.3 A    0.41   0.53 $\Omega$ FS   Forward Transconductance   V <sub>DS</sub> = -25 V, V <sub>GS</sub> = 0 V,<br>I =    4.1    S     Vpnamic Characteristics   f = 1.0 MHz    360   470   pF     rss   Notul Capacitance   f = 1.0 MHz    120   155   pF     rss   Num-On Delay Time   V <sub>DS</sub> = -25 V, V <sub>GS</sub> = 0 V,<br>I = -    110   30   ns     (off)   Turn-On Rise Time   N    10   20   | DSS   |  | V <sub>DS</sub> = -100 V, V <sub>GS</sub> = 0 V                                  |      | -           | -1    | μA    |
| SisserGate-Body Leakage Current, Reverse $V_{GS} = 30 \text{ V}, V_{DS} = 0 \text{ V}$ 100nAOn CharacteristicsGS(th)Gate Threshold Voltage $V_{DS} = V_{GS}, I_D = -250 \ \mu\text{A}$ -2.04.0VDS(on)Static Drain-Source<br>On-Resistance $V_{GS} = -10 \ V, I_D = -3.3 \ A$ 0.410.53 $\Omega$ EsForward Transconductance $V_{DS} = -40 \ V, I_D = -3.3 \ A$ 0.410.53 $\Omega$ Pynamic CharacteristicsissInput Capacitance $V_{DS} = -25 \ V, V_{GS} = 0 \ V, I_D = -3.3 \ A$ 120155pFrssReverse Transfer Capacitancef = 1.0 \ MHz3040pFwitching Characteristics(on)Turn-On Bias Time<br>Turn-On Rise Time $V_{DD} = -50 \ V, I_D = -8.0 \ A, I_D = -3.3 \ A$ 110230ns(off)Turn-On Rise Time<br>Turn-Off Fall Time $V_{DS} = -80 \ V, I_D = -8.0 \ A, I_D = -3.0 $ |   | Zero Gate Voltage Drain Current  | V <sub>DS</sub> = -80 V, T <sub>C</sub> = 125°C                                  |      |             | -10   | μA    |
| On CharacteristicsGS(Ih)Gate Threshold Voltage $V_{DS} = V_{GS}$ , $I_D = -250 \ \mu A$ -2.04.0VDS(on)Static Drain-Source<br>On-Resistance $V_{GS} = -10 \ V$ , $I_D = -3.3 \ A$ 0.410.53 $\Omega$ FSForward Transconductance $V_{DS} = -40 \ V$ , $I_D = -3.3 \ A$ 0.410.53 $\Omega$ Pynamic CharacteristicsissInput Capacitance $V_{DS} = -40 \ V$ , $I_D = -3.3 \ A$ (Note 4)4.1SPynamic CharacteristicsissInput Capacitance $V_{DS} = -25 \ V$ , $V_{GS} = 0 \ V$ , $360 \ 470 \ PF$ $F$ issNumut Capacitance $F = 1.0 \ MHz$ $120 \ 155 \ PF$ $F$ rssReverse Transfer Capacitance $F = 1.0 \ MHz$ $30 \ 400 \ PF$ witching Characteristics(on)Turn-On Delay Time $V_{DD} = -50 \ V$ , $I_D = -8.0 \ A$ , $11 \ 30 \ ns$ (off)Turn-Off Delay Time $V_{DS} = -80 \ V$ , $I_D = -8.0 \ A$ , $110 \ 230 \ ns$ (off)Turn-Off Fall Time $V_{DS} = -80 \ V$ , $I_D = -8.0 \ A$ , $12 \ 15 \ nC$ (off)Turn-Off Fall Time $V_{OS} = -10 \ V$ $3.0 \ \ nC$ (ggGate-Source Charge $V_{GS} = -10 \ V$ $3.0 \ \ nC$ (ggGate-Drain Charge $V_{OS} = -10 \ V$ $6.4 \ \ nC$ (note 4, 5) $6.4 \ \ nC$ $6.6 \ A$ (note 4, 5) $6.4 \ \ nC$ <   | GSSF  | Gate-Body Leakage Current, Forward   |  |      | -           | -100  | nA    |
| GS(th)Gate Threshold Voltage $V_{DS} = V_{GS}$ , $I_D = -250 \ \mu A$ -2.04.0VDS(on)Static Drain-Source<br>On-Resistance $V_{GS} = -10 \ V$ , $I_D = -3.3 \ A$ 0.410.53 $\Omega$ rsForward Transconductance $V_{DS} = -40 \ V$ , $I_D = -3.3 \ A$ 4.1StissInput Capacitance $V_{DS} = -40 \ V$ , $I_D = -3.3 \ A$ (Note 4)4.1S <b>bynamic Characteristics</b> tissInput Capacitance $V_{DS} = -25 \ V$ , $V_{GS} = 0 \ V$ ,<br>f = 1.0 MHz $360 \ 470 \ PF$ $120 \ 155 \ PF$ rsReverse Transfer Capacitancetwitching Characteristics(on)Turn-On Delay Time<br>Turn-On Rise Time $V_{DD} = -50 \ V$ , $I_D = -8.0 \ A$ ,<br>$R_G = 25 \ \Omega$ $11 \ 30 \ ns$ (off)Turn-Off Fall Time $V_{DS} = -80 \ V$ , $I_D = -8.0 \ A$ ,<br>$R_G = 25 \ \Omega$ $120 \ 50 \ ns$ (off)Turn-Off Fall Time $V_{DS} = -80 \ V$ , $I_D = -8.0 \ A$ ,<br>$R_G = 25 \ \Omega$ $12 \ 15 \ nC$ (off)Turn-Off Fall Time $V_{OS} = -10 \ V$ $3.0 \ \ nC$ $ \ 3.0 \ \ nC$ (gsGate-Drain Charge $V_{GS} = -10 \ V$ $6.4 \ \ nC$ $ \ 6.6 \ A$ (Note 4, 5) $6.4 \ \ nC$ $ \ 6.6 \ A$ $ \ 6.6 \ A$  | GSSR  | Gate-Body Leakage Current, Reverse   | $V_{GS}$ = 30 V, $V_{DS}$ = 0 V  |      |             | 100   | nA    |
| GS(th)Gate Threshold Voltage $V_{DS} = V_{GS}$ , $I_D = -250 \ \mu A$ -2.04.0VDS(on)Static Drain-Source<br>On-Resistance $V_{GS} = -10 \ V$ , $I_D = -3.3 \ A$ 0.410.53 $\Omega$ rsForward Transconductance $V_{DS} = -40 \ V$ , $I_D = -3.3 \ A$ 4.1StissInput Capacitance $V_{DS} = -40 \ V$ , $I_D = -3.3 \ A$ (Note 4)4.1S <b>bynamic Characteristics</b> tissInput Capacitance $V_{DS} = -25 \ V$ , $V_{GS} = 0 \ V$ ,<br>f = 1.0 MHz $360 \ 470 \ PF$ $120 \ 155 \ PF$ rsReverse Transfer Capacitancetwitching Characteristics(on)Turn-On Delay Time<br>Turn-On Rise Time $V_{DD} = -50 \ V$ , $I_D = -8.0 \ A$ ,<br>$R_G = 25 \ \Omega$ $11 \ 30 \ ns$ (off)Turn-Off Fall Time $V_{DS} = -80 \ V$ , $I_D = -8.0 \ A$ ,<br>$R_G = 25 \ \Omega$ $120 \ 50 \ ns$ (off)Turn-Off Fall Time $V_{DS} = -80 \ V$ , $I_D = -8.0 \ A$ ,<br>$R_G = 25 \ \Omega$ $12 \ 15 \ nC$ (off)Turn-Off Fall Time $V_{OS} = -10 \ V$ $3.0 \ \ nC$ $ \ 3.0 \ \ nC$ (gsGate-Drain Charge $V_{GS} = -10 \ V$ $6.4 \ \ nC$ $ \ 6.6 \ A$ (Note 4, 5) $6.4 \ \ nC$ $ \ 6.6 \ A$ $ \ 6.6 \ A$  | On Cha  | racteristics   |  |      |             |       |       |
|  | V <sub>GS(th)</sub>   |  | $V_{DS} = V_{GS}, I_{D} = -250 \ \mu A$  | -2.0 |             | -4.0  | V     |
| OpenationDescriptionDescriptionDescriptionOpenationInput Capacitance $V_{DS} = -25 \text{ V}, V_{GS} = 0 \text{ V},$<br>f = 1.0 MHz360470pFissInput Capacitancef = 1.0 MHz120155pFissReverse Transfer Capacitancef = 1.0 MHz3040pFwitching Characteristics(on)Turn-On Delay Time $V_{DD} = -50 \text{ V}, I_D = -8.0 \text{ A},$<br>$R_G = 25 \Omega$ 1130ns(off)Turn-On Rise Time $R_G = 25 \Omega$ 110230ns(off)Turn-Off Fall Time(Note 4, 5)3580nsgTotal Gate Charge $V_{DS} = -80 \text{ V}, I_D = -8.0 \text{ A},$<br>$V_{GS} = -10 \text{ V}$ 1215nCgdGate-Drain Charge $V_{DS} = -80 \text{ V}, I_D = -8.0 \text{ A},$<br>$V_{GS} = -10 \text{ V}$ 3.0nC(Note 4, 5)6.4nCorallGate-Drain Charge(Note 4, 5)6.4nCorallGate-Drain ChargeCharacteristics and Maximum Ratings6.6A   | R <sub>DS(on)</sub>   |  | V <sub>GS</sub> = -10 V, I <sub>D</sub> = -3.3 A                                 |      | 0.41        | 0.53  | Ω     |
| issInput Capacitance $V_{DS} = -25 V, V_{GS} = 0 V,$<br>f = 1.0 MHz360470pFossOutput Capacitancef = 1.0 MHz120155pFrssReverse Transfer Capacitancef = 1.0 MHz3040pFwitching Characteristics(on)Turn-On Delay Time $V_{DD} = -50 V, I_D = -8.0 A,$<br>$R_G = 25 \Omega$ 1130ns(off)Turn-Off Delay Time $V_{DD} = -50 V, I_D = -8.0 A,$<br>$R_G = 25 \Omega$ 110230ns(off)Turn-Off Fall Time $V_{DS} = -80 V, I_D = -8.0 A,$<br>$R_G = 25 \Omega$ 1215nC(off)Turn-Off Fall Time $V_{DS} = -80 V, I_D = -8.0 A,$<br>$R_G = 25 \Omega$ 1215nC(Note 4, 5)3.0nC3.0nC(off)Total Gate Charge<br>(gd $V_{GS} = -10 V$<br>(Note 4, 5)6.4nC(Note 4, 5)6.4nC6.4nC(not 4, 5)6.4nC6.4nC(Note 4, 5)6.4nC6.4nC(not 4, 5)6.4nC6.6A(a date-Drain ChargeMaximum Continuous Drain-Source Diode Forward Current6.6A   | Ĵfs   | Forward Transconductance   | V <sub>DS</sub> = -40 V, I <sub>D</sub> = -3.3 A (Note 4)                        |      | 4.1         |       | S     |
| Output Capacitance $f = 1.0 \text{ MHz}$ $$ $120$ $155$ $pF$ rssReverse Transfer Capacitance $f = 1.0 \text{ MHz}$ $$ $120$ $155$ $pF$ witching Characteristics(on)Turn-On Delay Time $V_{DD} = -50 \text{ V}, \text{ I}_D = -8.0 \text{ A},$ $$ $11$ $30$ nsTurn-On Rise Time $V_{DD} = -50 \text{ V}, \text{ I}_D = -8.0 \text{ A},$ $$ $110$ $230$ ns(off)Turn-Off Delay Time $R_G = 25 \Omega$ $$ $110$ $230$ ns $rag<$ Total Gate Charge $V_{DS} = -80 \text{ V}, \text{ I}_D = -8.0 \text{ A},$ $$ $12$ $155$ $nC$ $rg$ Total Gate Charge $V_{DS} = -80 \text{ V}, \text{ I}_D = -8.0 \text{ A},$ $$ $12$ $15$ $nC$ $rg$ Gate-Source Charge $V_{GS} = -10 \text{ V}$ $$ $3.0$ $$ $nC$ $rgd$ Gate-Drain Charge $V_{GS} = -10 \text{ V}$ $$ $6.4$ $$ $nC$ $reatin-Source Diode Characteristics and Maximum Ratings$  | Dynami  | c Characteristics  |  |      |             |       |       |
| ossOutput Capacitancef = 1.0 MHz120155pFrssReverse Transfer Capacitancef = 1.0 MHz3040pFwitching Characteristics(on)Turn-On Delay Time $V_{DD} = -50 V, I_D = -8.0 A,$ 1130nsTurn-On Rise Time $R_G = 25 \Omega$ 110230ns(off)Turn-Off Fall Time(Note 4, 5)3580nsgTotal Gate Charge $V_{DS} = -80 V, I_D = -8.0 A,$ 1215nCgsGate-Source Charge $V_{GS} = -10 V$ 3.0nCgdGate-Drain Charge(Note 4, 5)6.4nCtrain-Source Diode Characteristics and Maximum RatingsMaximum Continuous Drain-Source Diode Forward Current6.6A  | C <sub>iss</sub>  | Input Capacitance  | V <sub>DS</sub> = -25 V, V <sub>GS</sub> = 0 V,                                  |      | 360         | 470   | pF    |
| witching Characteristics(on)Turn-On Delay Time $V_{DD} = -50 \ V, \ I_D = -8.0 \ A, \ R_G = 25 \ \Omega$ 1130ns(off)Turn-Off Delay Time(Note 4, 5)110230ns(off)Turn-Off Fall Time(Note 4, 5)3580ns(Note 4, 5)Total Gate Charge $V_{DS} = -80 \ V, \ I_D = -8.0 \ A, \ V_{GS} = -10 \ V$ 1215nC(Note 4, 5)6.4nC(Note 4, 5)6.4nCPrain-Source Diode Characteristics and Maximum Ratings(a)Maximum Continuous Drain-Source Diode Forward Current6.6A   | C <sub>oss</sub>  | Output Capacitance   |  |      | 120         | 155   | pF    |
| $\begin{array}{c c c c c c c c c c c c c c c c c c c $   | C <sub>rss</sub>  | Reverse Transfer Capacitance   |  |      | 30          | 40    | pF    |
| Turn-Off Delay Time2050nsTurn-Off Fall Time(Note 4, 5)3580nsIgTotal Gate ChargeVDS = -80 V, ID = -8.0 A,<br>VGS = -10 V1215nCIgdGate-Drain ChargeVDS = -10 V3.0nCIgdGate-Drain Charge(Note 4, 5)6.4nCOrain-Source Diode Characteristics and Maximum RatingsIgdMaximum Continuous Drain-Source Diode Forward Current6.6A  | d(on)<br>r  |  | 66 6   |      |             |       |       |
| Turn-Off Fall Time(Note 4, 5)3580ns $g_g$ Total Gate Charge $V_{DS} = -80 \text{ V}, I_D = -8.0 \text{ A},$<br>$V_{GS} = -10 \text{ V}$ 1215nC $g_g$ Gate-Source Charge $V_{GS} = -10 \text{ V}$<br>(Note 4, 5)3.0nC $g_d$ Gate-Drain Charge $V_{GS} = -10 \text{ V}$<br>(Note 4, 5)6.4nCOrain-Source Diode Characteristics and Maximum Ratings $g_d$ Maximum Continuous Drain-Source Diode Forward Current6.6A  |   |  | $R_{G} = 25 \Omega$  |      |             |       | -     |
| gg Total Gate Charge VDS = -80 V, ID = -8.0 A, VGS = -10 V  12 15 nC   gg Gate-Source Charge VGS = -10 V  3.0  nC   gd Gate-Drain Charge VGS = -10 V (Note 4, 5)  6.4  nC   prain-Source Diode Characteristics and Maximum Ratings Maximum Continuous Drain-Source Diode Forward Current    -6.6 A   | f   |  | (Note 4, 5)  |      | -           |       |       |
| gs Gate-Source Charge VGS = -10 V  3.0  nC   gd Gate-Drain Charge VGS = -10 V (Note 4, 5)  6.4  nC   Orain-Source Diode Characteristics and Maximum Ratings Maximum Continuous Drain-Source Diode Forward Current    6.6 A   | ,<br>ל <sup>מ</sup>   |  | $V_{22} = -80 V I_2 = -80 A$   |      |             |       | -     |
| gd Gate-Drain Charge Gate-Drain Charge Note 4, 5)  6.4  nC   Orain-Source Diode Characteristics and Maximum Ratings Maximum Continuous Drain-Source Diode Forward Current   6.6 A  | 0   | •  | 50 5   |      | 3.0         |       |       |
| Antiperation   Antiperation     Antiperation   Antiperation     Antiperation   Antiperation     Antiperation   Antiperation  | •   | Gate-Drain Charge  |  |      | 6.4         |       | nC    |
| M Maximum Pulsed Drain-Source Diode Forward Current26.4 A  | S   | Maximum Continuous Drain-Source Diode Forward Current  |  |      |             |       |       |
|  |   |  |  |      |             |       |       |
| $r_{sp}$   Drain-Source Diode Forward Voltage   $V_{cs} = 0$ V $l_s = -6.6$ A $$ $$ $-4.0$ V   |   |  |  |      |             |       |       |
|  | Q <sub>rr</sub>   | •  |  |      |             |       |       |
|  | Q <sub>gs</sub><br>Q <sub>gd</sub><br>Drain-S<br>I <sub>S</sub><br>I <sub>SM</sub><br>V <sub>SD</sub> | Gate-Drain Charge<br>ource Diode Characteristics ar<br>Maximum Continuous Drain-Source Dio   | V <sub>GS</sub> = -10 V (Note 4, 5)<br>Ad Maximum Ratings<br>ode Forward Current |      | 6.4<br><br> | -26.4 |       |
| SD   Drain-Source Diode Forward Voltage   $V_{CS} = 0$ V $I_S = -6.6$ A  | rr  |  |  |      | 98          |       | ns    |
|  |   | •  |  |      |             |       |       |
| $V_{GS} = 0 V, I_S = -8.0 A,98 ns$   |   |  | 1  | 1    |             | 1     |       |
|  | L = 5.2mH, I,<br>I <sub>SD</sub> $\leq$ -8.0A,  | ating : Pulse width limited by maximum junction temper<br>$A_S = -6.6A$ , $V_{DD} = -25V$ , $R_G = 25 \Omega$ , Starting $T_J = 25^{\circ}C$<br>$di/dt \leq 300A/\mu_s$ , $V_{DD} \leq BV_{DSS}$ , Starting $T_J = 25^{\circ}C$<br>Pulse width $\leq 300\mu_s$ , Duty cycle $\leq 2\%$<br>dependent of operating temperature |  |      |             |       |       |

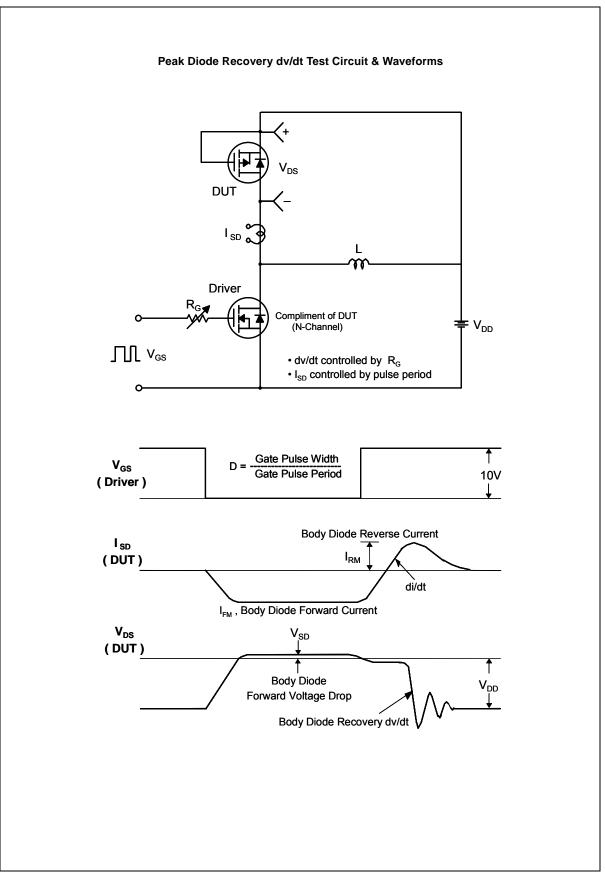


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